



Vishay Siliconix

# N-Channel 100-V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	$r_{DS(on)}\left(\Omega\right)$	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ)		
100	0.026 at V <sub>GS</sub> = 10 V	35	31 nC		

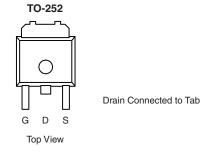
#### **FEATURES**

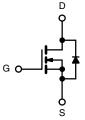
- TrenchFET® Power MOSFET
- 100 % UIS Tested



#### **APPLICATIONS**

· Primary Side Switch





Ordering Information: SUD35N10-26P-E3 (Lead (Pb)-free)

N-Channel MOSFET

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V <sub>DS</sub>	100	V	
Gate-Source Voltage	V <sub>GS</sub>	± 20	V	
	T <sub>C</sub> = 25 °C		35	
Continuous Drain Current /T = 175 °C)	T <sub>C</sub> = 70 °C		32	
Continuous Drain Current (T <sub>J</sub> = 175 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	12 <sup>b, c</sup>	
	T <sub>A</sub> = 70 °C		10 <sup>b, c</sup>	
Pulsed Drain Current		I <sub>DM</sub>	40	A
0 11 0 0 0 1	T <sub>C</sub> = 25 °C	1	50 <sup>e</sup>	
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	6.9 <sup>b, c</sup>	
Avalanche Current Pulse		I <sub>AS</sub>	33	
Single Pulse Avalanche Energy	L = 0.1 mH	E <sub>AS</sub>	55	mJ
	T <sub>C</sub> = 25 °C		83	
Maximum Power Dissipation	T <sub>C</sub> = 70 °C		58	144
	T <sub>A</sub> = 25 °C	P <sub>D</sub>	8.3 <sup>b, c</sup>	W
	T <sub>A</sub> = 70 °C		5.8 <sup>b, c</sup>	
Operating Junction and Storage Temperature Ra	ange	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 175	°C

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>b, d</sup>	t ≤ 10 s	$R_{thJA}$	15	18	°C/W	
Maximum Junction-to-Case	Steady State	$R_{thJC}$	1.5	1.8	C/VV	

#### Notes

- a. Based on  $T_C$  = 25 °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. Maximum under Steady State conditions is 50  $^{\circ}\text{C/W}.$
- e. Calculated based on maximum junction temperature. Package limitation current is 50 A.

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static						I	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	100			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050A		165		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	$I_D = 250 \mu A$		- 11			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2.5		4.4	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V		1		<b>—</b>	
		$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 \text{ °C}$			10	μΑ	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	40			Α	
Drain-Source On-State Resistance <sup>a</sup>	r <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 12 A		0.021	0.026	Ω	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 12 A		25		S	
Dynamic <sup>b</sup>	<u>'</u>		I.	1			
Input Capacitance	C <sub>iss</sub>			2000		pF	
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 12 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		180			
Reverse Transfer Capacitance	C <sub>rss</sub>			60			
Total Gate Charge	$Q_g$			31	47		
Gate-Source Charge	$Q_{gs}$	$V_{DS} = 50 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 12 \text{ A}$		10		nC	
Gate-Drain Charge	$Q_{gd}$			9			
Gate Resistance	$R_{g}$	f = 1 MHz		1.5		Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			10	15	- ns	
Rise Time	t <sub>r</sub>	$V_{DD} = 50 \text{ V}, R_L = 5 \Omega$		10	15		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D\cong 10$ A, $V_{GEN}=10$ V, $R_g=1$ $\Omega$		15	25		
Fall Time	t <sub>f</sub>			10	15		
Drain-Source Body Diode Characteristic	s					•	
Continuous Source-Drain Diode Current	I <sub>S</sub>	$T_C = 25  ^{\circ}C$			50		
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				40	Α	
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = 10 A		0.8	1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			50	75	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> = 10 A, di/dt = 100 A/μs, T <sub>.I</sub> = 25 °C		100	150	nC	
Reverse Recovery Fall Time	t <sub>a</sub>			38		no	
Reverse Recovery Rise Time	t <sub>b</sub>	7		12		ns	

#### Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %.

b. Guaranteed by design, not subject to production testing.

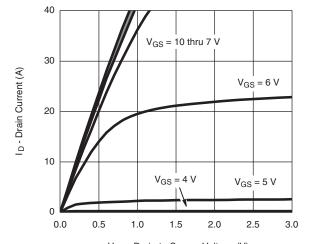
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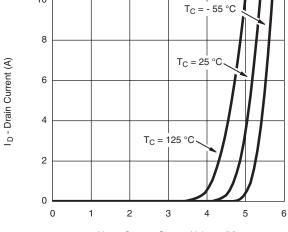


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## TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

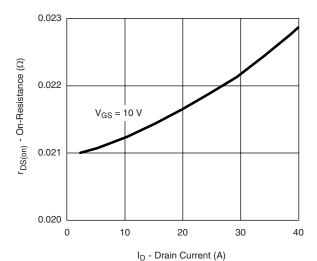


V<sub>DS</sub> - Drain-to-Source Voltage (V)

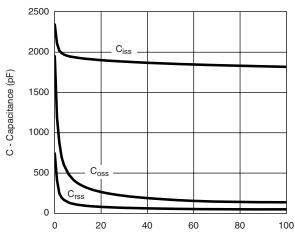


V<sub>GS</sub> - Gate-to-Source Voltage (V) **Transfer Characteristics** 

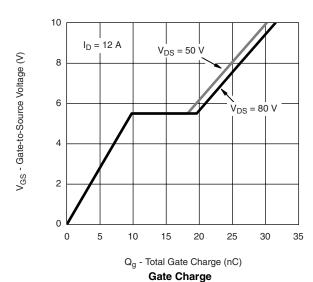


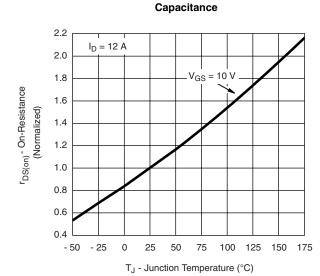


On-Resistance vs. Drain Current



V<sub>DS</sub> - Drain-to-Source Voltage (V)



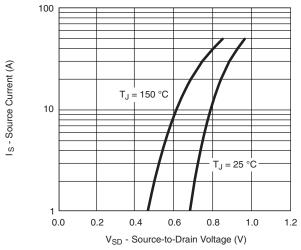


On-Resistance vs. Junction Temperature

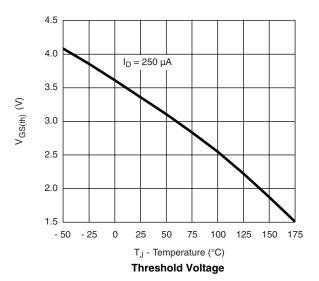
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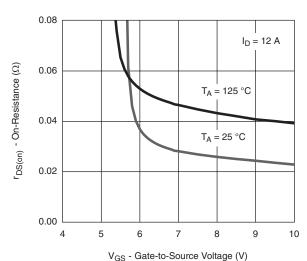
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### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

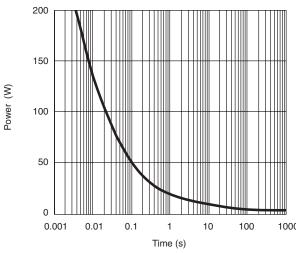


#### Source-Drain Diode Forward Voltage

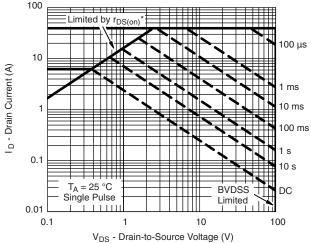




r<sub>DS(on)</sub> vs. V<sub>GS</sub> vs. Temperature



Single Pulse Power, Junction-to-Ambient



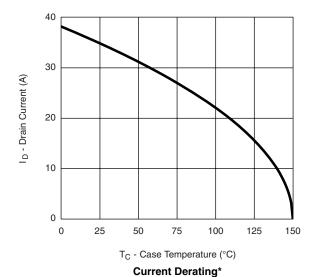
 $^{\star}$   $V_{GS}$  >  $\,$  minimum  $V_{GS}$  at which  $r_{DS(on)}$  is specified

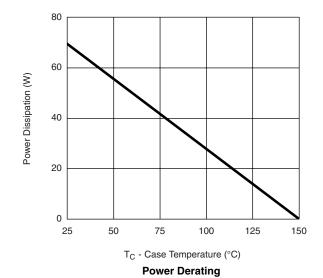
Safe Operating Area



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## TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





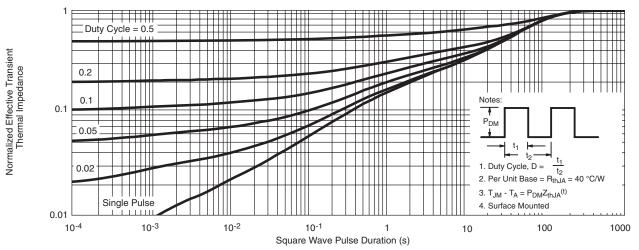
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<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

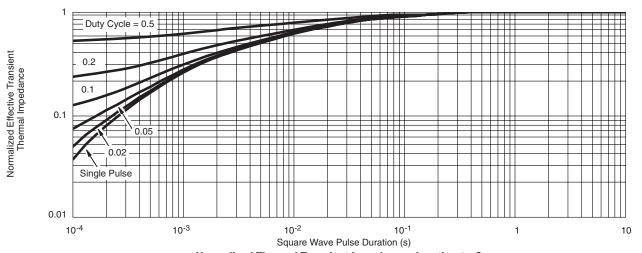
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#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



#### Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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